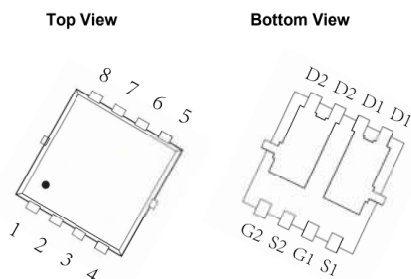


Dual N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (m Ω)(Typ.)	I_D (A) ^{a, d}	Q_g (Typ.)
40	12 at $V_{GS} = 10$ V	23	8 nC
	21 at $V_{GS} = 4.5$ V		

PDFN3.3X3.3



FEATURES

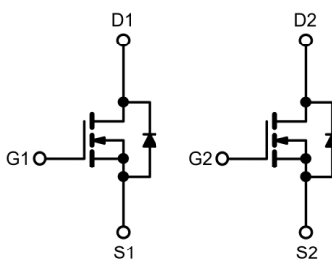
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested



RoHS
COMPLIANT

APPLICATIONS

- Switching Application Systems
- On board power for server



Dual N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	40	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 175$ °C)	$T_C = 25$ °C	I_D	23 ^{a, d}	A
	$T_C = 70$ °C		16 ^d	
	$T_A = 25$ °C		11 ^{b, c}	
	$T_A = 70$ °C		8 ^{b, c}	
Pulsed Drain Current		I_{DM}	88	
Avalanche Current Pulse	$L = 0.1$ mH	I_{AS}	20	
Single Pulse Avalanche Energy		E_{AS}	6	mJ
Continuous Source-Drain Diode Current	$T_C = 25$ °C	I_S	23 ^{a, d}	A
	$T_A = 25$ °C		11 ^{b, c}	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	15 ^a	W
	$T_C = 70$ °C		8	
	$T_A = 25$ °C		2.9 ^{b, c}	
	$T_A = 70$ °C		1.5 ^{b, c}	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	$t \leq 10$ s	R_{thJA}	30	45	°C/W
Maximum Junction-to-Case	Steady State	R_{thJC}	5.5	9	

Notes:

a. Based on $T_C = 25$ °C.

b. Surface mounted on 1" x 1" FR4 board.

c. $t = 10$ s.

d. Calculated based on maximum junction temperature.

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min .	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	40			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		33		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			-4.5		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1		3	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V			1	μA
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	23			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 10 A		12	18	mΩ
		V _{GS} = 4.5 V, I _D = 8 A		21	30	
Forward Transconductance ^a	g _{fs}	V _{DS} = 5 V, I _D = 10 A		35		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		415		pF
Output Capacitance	C _{oss}			203		
Reverse Transfer Capacitance	C _{rss}			21		
Total Gate Charge	Q _g	V _{DS} = 20 V, V _{GS} = 10 V, I _D = 10 A		8		nC
Gate-Source Charge	Q _{gs}			3		
Gate-Drain Charge	Q _{gd}			5		
Gate Resistance	R _g	f = 1 MHz		1		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 20 V, R _L = 0.555 I _D = 10 A, V _{GEN} = 10 V, R _g = 1		10		ns
Rise Time	t _r			15		
Turn-Off Delay Time	t _{d(off)}			23		
Fall Time	t _f			10		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			23	A
Pulse Diode Forward Current ^a	I _{SM}				88	
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C		18		ns
Body Diode Reverse Recovery Charge	Q _{rr}			25		nC
Reverse Recovery Fall Time	t _a			11		ns
Reverse Recovery Rise Time	t _b			15		

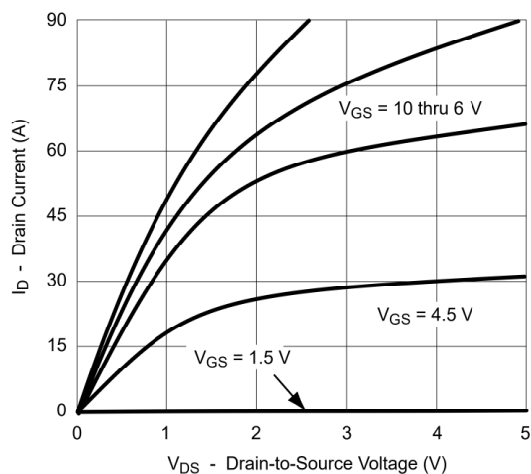
Notes:

a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

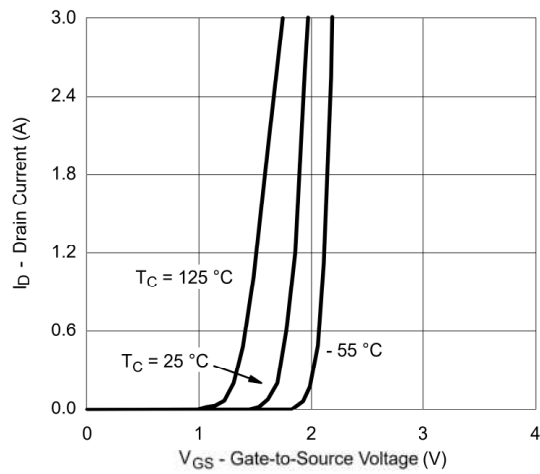
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

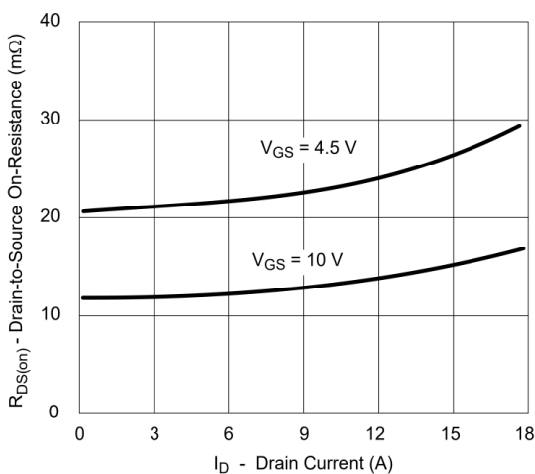
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



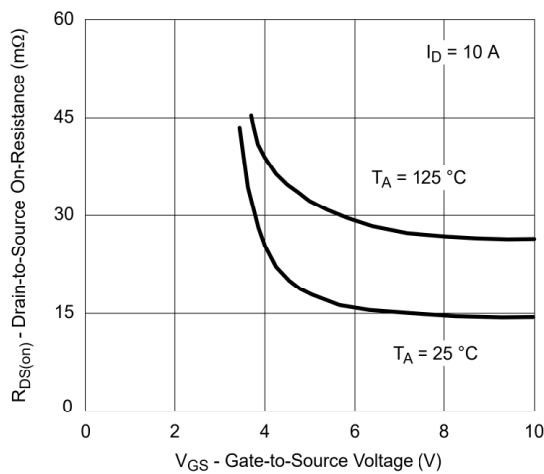
Output Characteristics



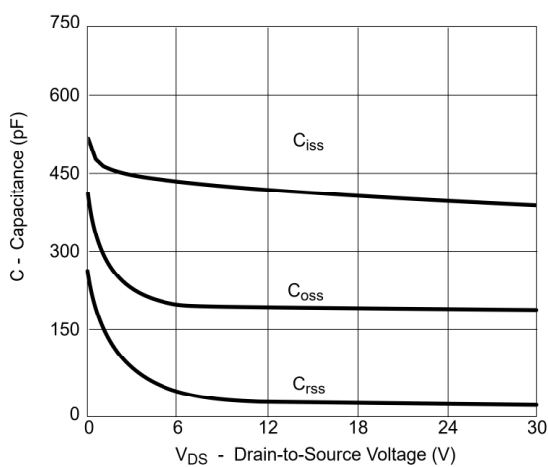
Transfer Characteristics



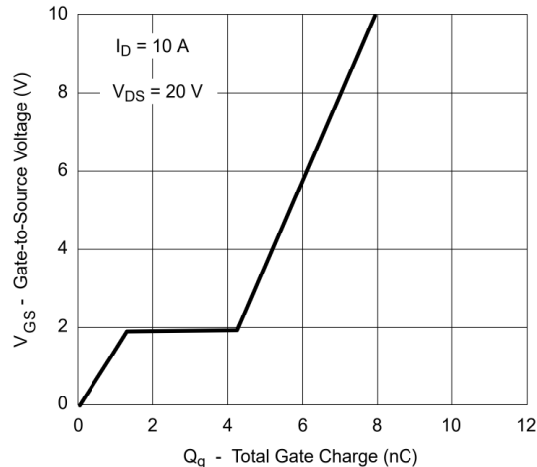
$R_{DS(on)}$ vs. Drain Current



$R_{DS(on)}$ vs. V_{GS} vs. Temperature

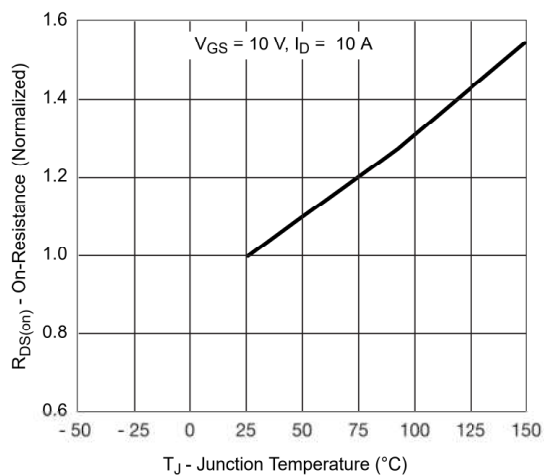


Capacitance

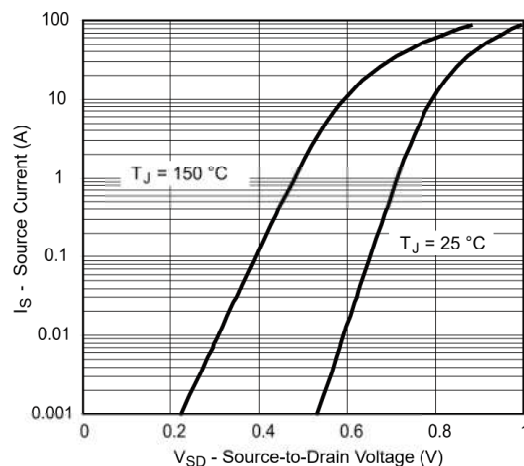


Gate Charge

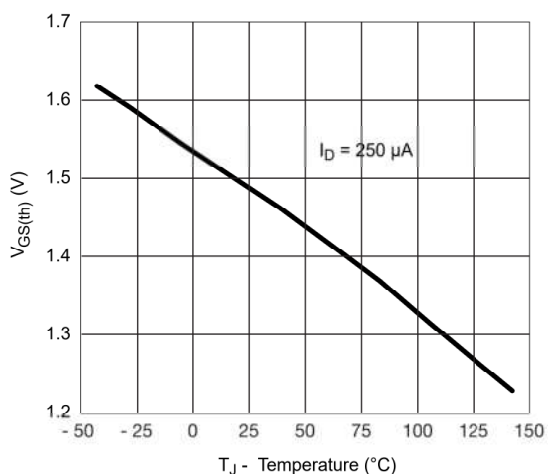
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



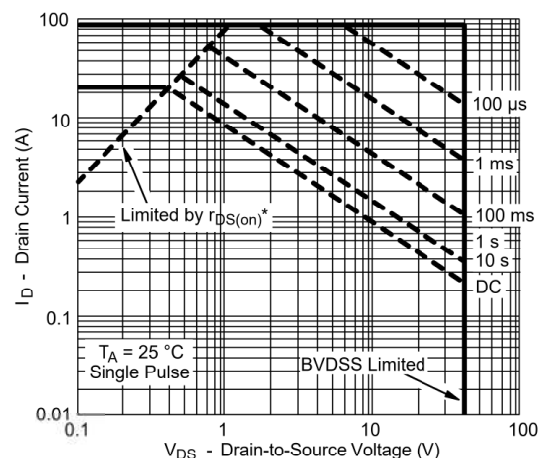
On-Resistance vs. Junction Temperature



Forward Diode Voltage vs. Temperature

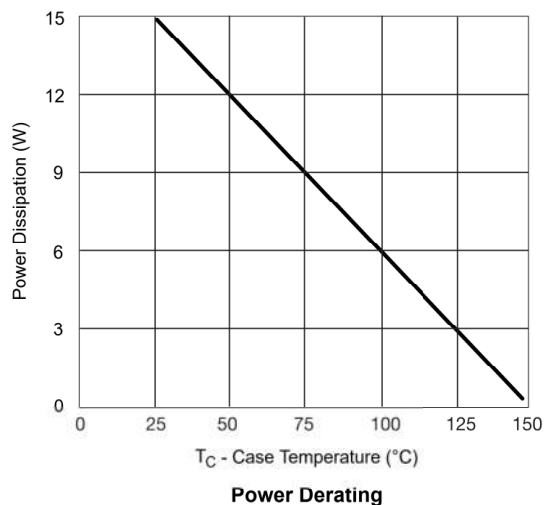
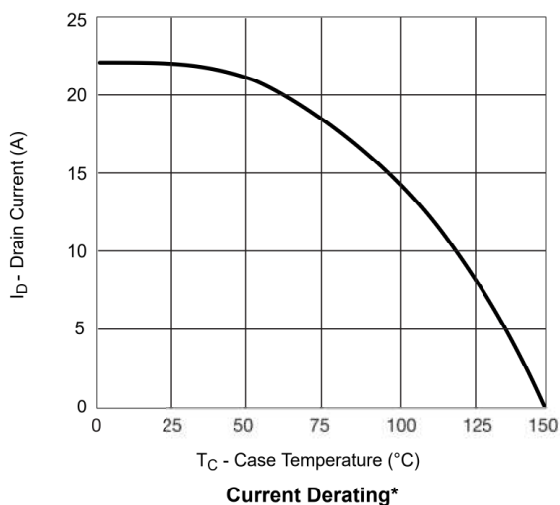


Threshold Voltage

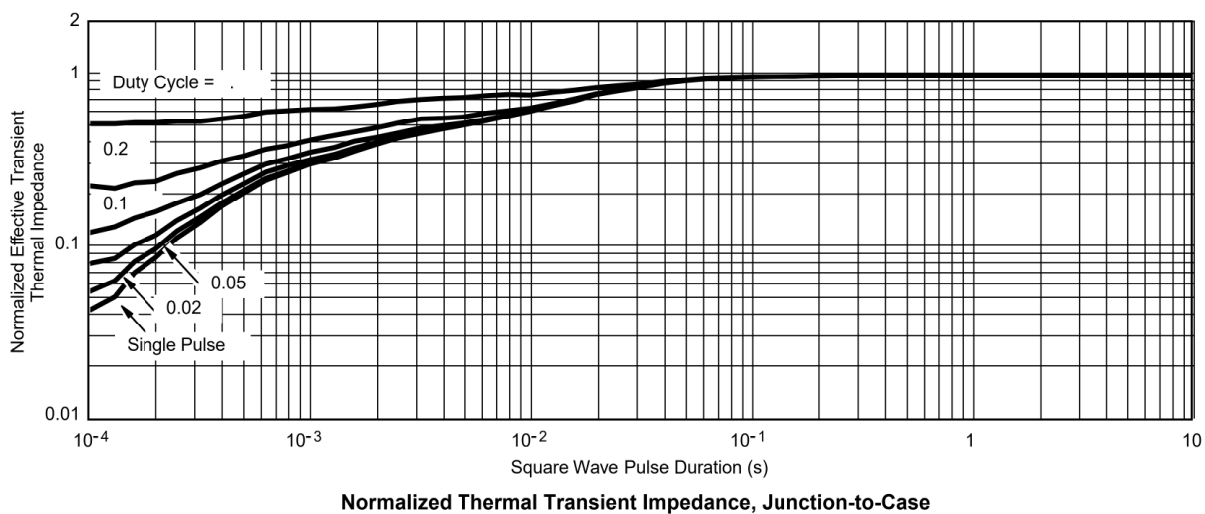


Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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